

## FCC PART 15B, CLASS B TEST REPORT

For

### SWAGTEK

10205 NW 19th Street STE101 Miami, Florida 33172 United States

**FCC ID: O55242518**

<b>Report Type:</b> Class II Permissive Change	<b>Product Type:</b> 2.4 inch 3G Flip Phone
<b>Report Number:</b> RSZ190611001-00AA1	
<b>Report Date:</b> 2019-07-31	
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## GENERAL INFORMATION

### Product Description for Equipment under Test (EUT)

Product	2.4 inch 3G Flip Phone
Tested Model	F8G
Multiple Model <sup>#</sup>	FLIP G, U8G
Voltage Range	DC 3.7 V from battery or DC 5.0V from adapter
Highest operating frequency	2480 MHz
Date of Test	2019-06-14
Sample serial number	190611001
Received date	2019-06-11
Sample/EUT Status	Good condition
Adapter information	Model: XCM04-X0505000YU Input: AC 100-240V, 50/60Hz, 0.15A Output: DC 5.0V, 500mA

Model	Trade Name
F8G	LOGIC
FLIP G	iSWAG
U8G	UNONU

Notes: This series products model: FLIP G, U8G and F8G are electrically identical, model F8G was selected for fully testing, the detailed information can be referred to the declaration letter.

### Objective

This test report is prepared on behalf of SWAGTEK in accordance with Part 2-Subpart J, Part 15-Subparts A, B of the Federal Communication Commissions rules.

The objective of the manufacturer is to determine the compliance of the EUT with FCC Part 15 B.

This is a CIIPC application of the device; the differences between the original device and the current one are as follows:

1. Updating the single card to double card.
2. Changing the 2G&3G antenna.
3. Changing the label on adapter but the circuit parameter didn't change.
4. Changing the model number from "LOGIC F8G, iSWAG FLIP G, UNONU U8G, UNONU F8G" to "F8G, FLIP G, U8G".

Based on above differences, it will affect the test item of "Radiated Spurious Emissions", so we updated the test data and setup photos of this item.

### Related Submittal(s)/Grant(s)

FCC Part 15.247 DSS and FCC Part 22H&24E PCE submissions with FCC ID: O55242518.

## Test Methodology

All measurements contained in this report were conducted with ANSI C63.4-2014, American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the range of 9 kHz to 40 GHz.

All emissions measurement was performed at Bay Area Compliance Laboratories Corp. (Shenzhen). The radiated testing was performed at an antenna-to-EUT distance of 3 meters.

## Measurement Uncertainty

All measurements involve certain levels of uncertainties, especially in field of EMC. The factors contributing to uncertainties are spectrum analyzer, cable loss, antenna factor calibration, antenna directivity, antenna factor variation with height, antenna phase center variation, antenna factor frequency interpolation, measurement distance variation, site imperfections, mismatch (average), and system repeatability.

Based on CISPR 16-4-2:2011, the expended combined standard uncertainty of test at Bay Area Compliance Laboratories Corp. (Shenzhen) is shown as below. And the uncertainty will be taken into consideration for the test data recorded in the report

Parameter		uncertainty
Conducted Emissions		±1.95dB
Emissions, radiated	Below 1GHz	±4.75dB
	Above 1GHz	±4.88dB

*Note: Otherwise required by the applicant or Product Regulations, Decision Rule in this report did not consider the uncertainty.*

## Test Facility

The Test site used by Bay Area Compliance Laboratories Corp. (Shenzhen) to collect test data is located on the 6/F., West Wing, Third Phase of Wanli Industrial Building, Shihua Road, Futian Free Trade Zone, Shenzhen, Guangdong, China.

The test site has been approved by the FCC under the KDB 974614 D01 and is listed in the FCC Public Access Link (PAL) database, FCC Registration No.: 342867, the FCC Designation No.: CN1221.

The test site has been registered with ISED Canada under ISED Canada Registration Number 3062B.

## SYSTEM TEST CONFIGURATION

### Description of Test Configuration

The system was configured for testing in a manufacturer testing fashion.

EUT operation mode: Downloading (data transfer with computer)

### EUT Exercise Software

“BurnIn test v5.3” exercise software was used.

### Special Accessories

No special accessory.

### Equipment Modifications

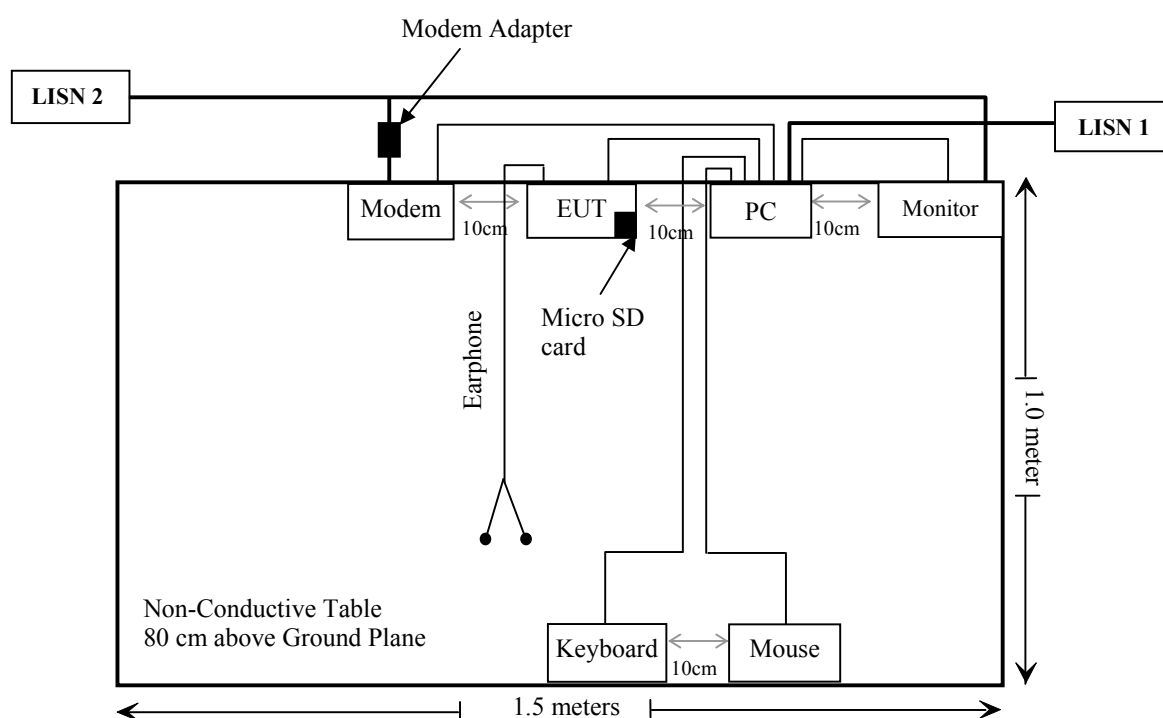
No modification was made to the EUT tested.

### Support Equipment List and Details

Manufacturer	Description	Model	Serial Number
DELL	Host PC	DCSCSF	127BP2X
TCL	Monitor	TFT1560PS	ALA560806C160409
Microsoft	Keyboard	1406	0200706128743
DELL	Mouse	MOC5UO	G1900NKD
SAST	Modem	AEM-2100	0293
Kingston	Micro SD card	1 GB	N/A
Unknown	USB Cable	Unknown	Unknown

**External I/O Cable**

Cable Description	Length (m)	From/Port	To
Un-Shielding Detachable USB Cable	1.5	Host PC	Mouse
Shielding Detachable Serial Cable	1.2	Host PC	Modem
Shielding Detachable K/B Cable	1.5	Host PC	Keyboard
Shielding Detachable VGA Cable	1.5	Host PC	LCD Monitor
Un-Shielding Detachable USB Cable	1.0	EUT	Host PC
Un-shielding Detachable Earphone Cable	1.2	EUT	Earphone

**Block Diagram of Test Setup**

**SUMMARY OF TEST RESULTS**

FCC Rules	Description of Test	Results
§15.107	AC Line Conducted Emissions	Compliance*
§15.109	Radiated Spurious Emissions	Compliance

Note:

Compliance\*: Please referred to FCC ID: O55242518 granted on 2018-10-11. Report No.: HUAK180803686E, which was tested by Shenzhen HUAK Testing Technology Co., Ltd.

Compliance: RE below 1G test BACL, RE above 1G please referred to FCC ID: O55242518 granted on 2018-10-11. Report No.: HUAK180803686E, which was tested by Shenzhen HUAK Testing Technology Co., Ltd.

**TEST EQUIPMENT LIST**

Manufacturer	Description	Model	Serial Number	Calibration Date	Calibration Due Date
<b>Radiated Emission Test</b>					
Sunol Sciences	Broadband Antenna	JB1	A040904-1	2017-12-22	2020-12-21
Sonoma Instrument	Amplifier	310N	186238	2018-11-12	2019-11-12
Rohde & Schwarz	EMI Test Receiver	ESR	1316.3003K03 -101746-zn	2018-07-11	2019-07-11
Rohde & Schwarz	Auto test software	EMC 32	V9.10	NCR	NCR
Ducommun Technologies	RF Cable	RG-214	1	2019-05-21	2019-11-19
Ducommun Technologies	RF Cable	RG-214	2	2018-11-12	2019-11-12

\* **Statement of Traceability:** Bay Area Compliance Laboratories Corp. (Shenzhen) attests that all calibrations have been performed in accordance to requirements that traceable to National Primary Standards and International System of Units (SI).



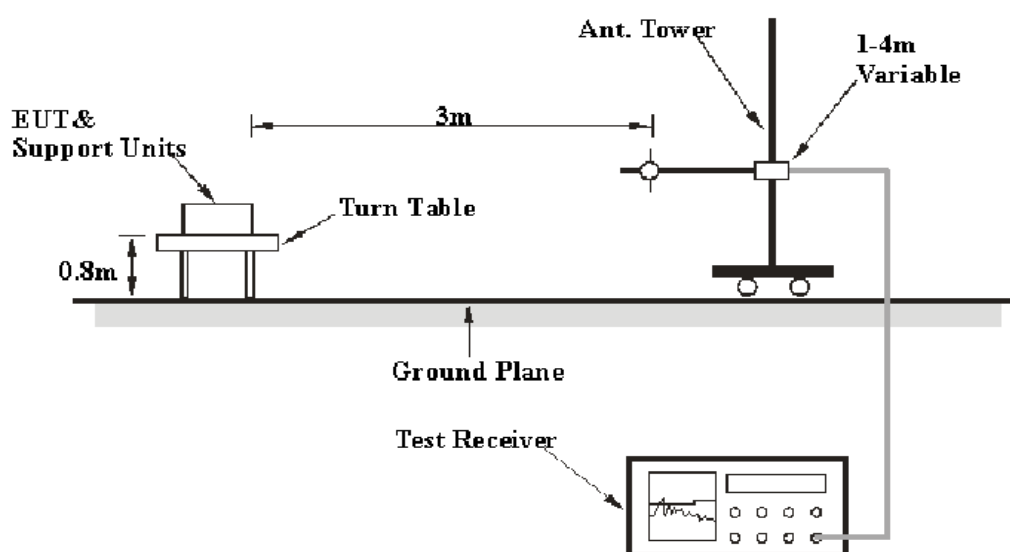
## FCC §15.109 - RADIATED SPURIOUS EMISSIONS

### Applicable Standard

FCC §15.109

### EUT Setup

Below 1GHz:



The radiated emission tests were performed in the 3 meters chamber test site, using the setup accordance with the ANSI C63.4-2014. The specification used was the FCC Part 15.109 Class B limits.

The external I/O cables were draped along the test table and formed a bundle 30 to 40 cm long in the middle.

The spacing between the peripherals was 10 cm.

### EMI Test Receiver Setup

The system was investigated from 30 MHz to 1 GHz.

During the radiated emission test, the EMI test receiver was set with the following configurations:

Frequency Range	RBW	Video B/W	IF B/W	Measurment
30 MHz – 1000 MHz	100 kHz	300 kHz	120 kHz	QP

## Test Procedure

Maximizing procedure was performed on the highest emissions to ensure that the EUT complied with all installation combinations.

All data was recorded in the Quasi-peak detector mode from 30 MHz to 1 GHz.

## Corrected Amplitude & Margin Calculation

The Corrected Amplitude is calculated by adding the Antenna Factor and Cable Loss, and subtracting the Amplifier Gain from the Meter Reading. The basic equation is as follows:

$$\text{Corrected Amplitude} = \text{Meter Reading} + \text{Antenna Factor} + \text{Cable Loss} - \text{Amplifier Gain}$$

The “**Margin**” column of the following data tables indicates the degree of compliance with the applicable limit. For example, a margin of 7 dB means the emission is 7 dB below the limit. The equation for margin calculation is as follows:

## Test Results Summary

According to the data in the following table, the EUT complied with the FCC §15.109 Class B,

Refer to CISPR16-4-2:2011 and CISPR 16-4-1:2009, the measured level is in compliance with the limit if

$$L_m + U_{(Lm)} \leq L_{lim} + U_{cispr}$$

In BACL,  $U_{(Lm)}$  is less than  $U_{cispr}$ , if  $L_m$  is less than  $L_{lim}$ , it implies that the EUT complies with the limit.

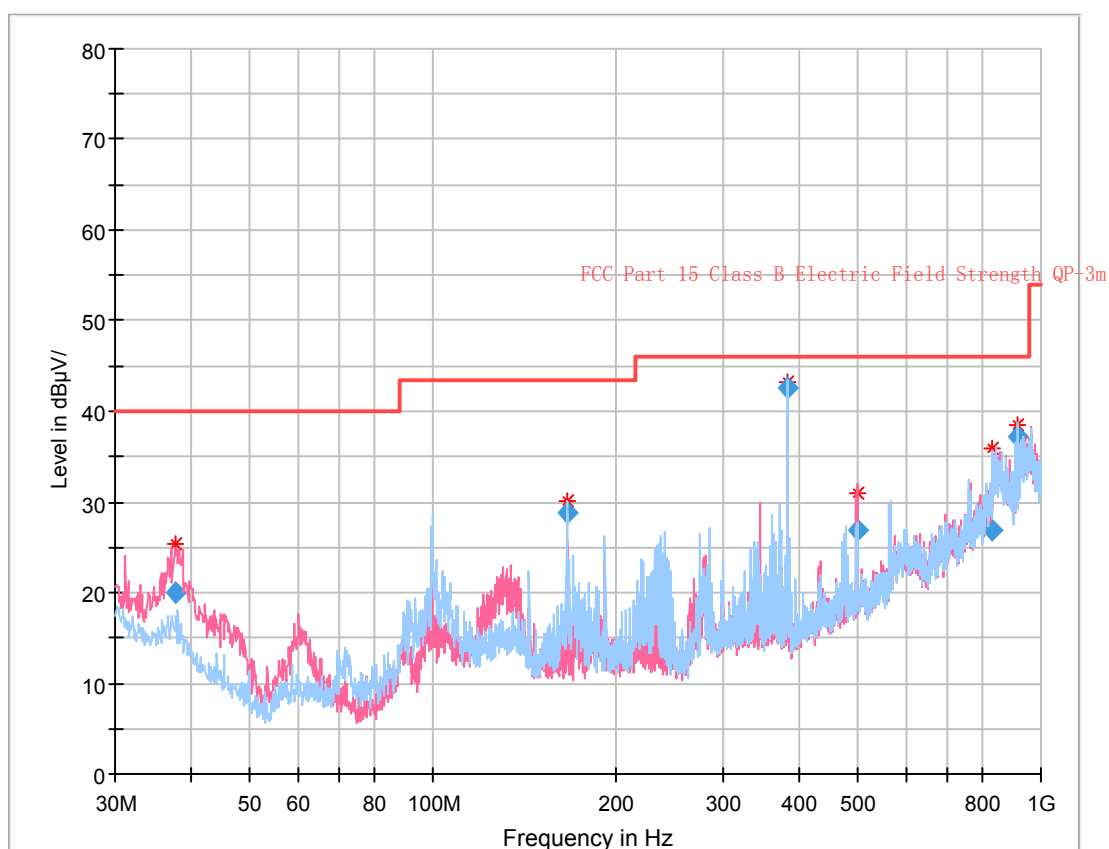
## Test Data

### Environmental Conditions

Temperature:	25 °C
Relative Humidity:	50 %
ATM Pressure:	101.0 kPa

*The testing was performed by Andy Yu on 2019-06-14.*

*EUT Operation Mode: Downloading*

**30 MHz~1 GHz:**

Frequency (MHz)	Corrected Amplitude (dBμV/m)	Antenna height (cm)	Antenna Polarity	Turntable position (degree)	Correction Factor (dB/m)	Limit (dBμV/m)	Margin (dB)
37.613875	19.91	126.0	V	212.0	-12.2	40.00	20.09
166.545250	28.89	253.0	H	74.0	-14.8	43.50	14.61
384.003500	42.61	134.0	H	123.0	-10.5	46.00	3.39
497.778000	26.92	106.0	V	146.0	-7.2	46.00	19.08
828.624750	26.97	270.0	H	23.0	4.8	46.00	19.03
914.835500	37.25	145.0	H	112.0	5.9	46.00	8.75

**Note:**

- 1) Correction Factor=Antenna factor (RX) + cable loss – amplifier factor
- 2) Corrected Amplitude = Correction Factor + Reading
- 3) Margin = Limit - Corrected Amplitude

\*\*\*\*\* END OF REPORT \*\*\*\*\*